

<b>Notice of References Cited</b>	Application/Control No. 10/633,522	Applicant(s)/Patent Under Reexamination SHIGENO ET AL.	
	Examiner Shih-wen Hsieh	Art Unit 2861	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,010,203	01-2000	Muraki, Motohito	347/30
	C	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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